## **General Description**

The MAX19713 is an ultra-low-power, highly integrated mixed-signal analog front-end (AFE) ideal for wideband communication applications operating in full-duplex (FD) mode. Optimized for high dynamic performance and ultra-low power, the device integrates a dual 10-bit, 45Msps receive (Rx) ADC; dual 10-bit, 45Msps transmit (Tx) DAC; three fast-settling 12-bit aux-DAC channels for ancillary RF front-end control; and a 10-bit, 333ksps housekeep-ing aux-ADC. The typical operating power in FD mode is 91.8mW at a 45MHz clock frequency.

The Rx ADCs feature 54dB SINAD and 72.2dBc SFDR at 5.5MHz input frequency with a 45MHz clock frequency. The analog I/Q input amplifiers are fully differential and accept  $1.024V_{P-P}$  full-scale signals. Typical I/Q channel matching is  $\pm 0.03$  phase and  $\pm 0.02dB$  gain.

The Tx DACs feature 70.3dBc SFDR at  $f_{OUT}$  = 2.2MHz and  $f_{CLK}$  = 45MHz. The analog I/Q full-scale output voltage range is ±400mV differential. The output DC common-mode voltage is selectable from 0.71V to 1.06V. The I/Q channel offset is adjustable to optimize radio lineup sideband/carrier suppression. Typical I/Q channel matching is ±0.01dB gain and ±0.05° phase.

Two independent 10-bit parallel, high-speed digital buses used by the Rx ADC and Tx DAC allow full-duplex operation for frequency-division duplex applications. The Rx ADC and Tx DAC can be disabled independently to optimize power management. A 3-wire serial interface controls power-management modes, the aux-DAC channels, and the aux-ADC channels.

The MAX19713 operates on a single 2.7V to 3.3V analog supply and 1.8V to 3.3V digital I/O supply. The MAX19713 is specified for the extended (-40°C to +85°C) temperature range and is available in a 56-pin, TQFN package. The <u>Selector Guide</u> at the end of the data sheet lists other pin-compatible versions in this AFE family. For time-division duplex (TDD) applications, refer to the MAX19705–MAX19708 AFE family of products.

## **Applications**

WiMAX CPEs801.11a/b/g WLAN

VoIP Terminals

 Portable Communication Equipment

# Ordering Information

PART*	PIN-PACKAGE	PKG CODE
MAX19713ETN	56 TQFN-EP**	T5677-1
MAX19713ETN+	56 TQFN-EP**	T5677-1

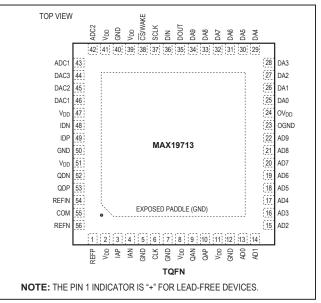
\*All devices are specified over the -40°C to +85°C operating range. \*\*EP = Exposed paddle. +Denotes lead-free package.

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

### **Features**

- Dual 10-Bit, 45Msps Rx ADC and Dual 10-Bit, 45Msps Tx DAC
- Ultra-Low Power
  - 91.8mW at f<sub>CLK</sub> = 45MHz, FD Mode
  - 79.2mW at f<sub>CLK</sub> = 45MHz, Slow Rx Mode
  - 49.5mW at f<sub>CLK</sub> = 45MHz, Slow Tx Mode
  - · Low-Current Standby and Shutdown Modes
- Programmable Tx DAC Common-Mode DC Level and I/Q Offset Trim
- Excellent Dynamic Performance
  - SNR = 54.1dB at f<sub>IN</sub> = 5.5MHz (Rx ADC)
  - SFDR = 70.3dBc at f<sub>OUT</sub> = 2.2MHz (Tx DAC)
- Three 12-Bit, 1µs Aux-DACs
- 10-Bit, 333ksps Aux-ADC with 4:1 Input Mux and Data Averaging
- Excellent Gain/Phase Match
  - +  $\pm 0.03^{\circ}$  Phase,  $\pm 0.02$ dB Gain (Rx ADC) at f<sub>IN</sub> = 5.5MHz
- Multiplexed Parallel Digital I/O
- Serial-Interface Control
- Versatile Power-Control Circuits
  Shutdown, Standby, Idle, Tx/Rx Disable
- Miniature 56-Pin TQFN Package (7mm x 7mm x 0.8mm)

## **Pin Configuration**



Functional Diagram and Functional Diagram appear at end of data sheet.



# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Absolute Maximum Ratings**

V <sub>DD</sub> to GND, OV <sub>DD</sub> to OGND0.3V to +3.6V
GND to OGND0.3V to +0.3V
IAP, IAN, QAP, QAN, IDP, IDN, QDP,
QDN, DAC1, DAC2, DAC3 to GND0.3V to V <sub>DD</sub>
ADC1, ADC2 to GND0.3V to (V <sub>DD</sub> + 0.3V)
REFP, REFN, REFIN, COM to GND0.3V to (V <sub>DD</sub> + 0.3V)
AD0–AD9, DA0–DA9, SCLK, DIN, CS/WAKE,
CLK, DOUT to OGND0.3V to (OV <sub>DD</sub> + 0.3V)

Continuous Power Dissipation ( $T_A = +70^{\circ}C$ )	
56-Pin TQFN-EP (derate 27.8mW/°C above +70°C)	2.22W
Thermal Resistance $\theta_{JA}$	36°C/W
Operating Temperature Range40°C	to +85°C
Junction Temperature	+150°C
Storage Temperature Range60°C to	o +150°C
Lead Temperature (soldering, 10s)	+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## **Electrical Characteristics**

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
POWER REQUIREMENTS	÷					
Analog Supply Voltage	V <sub>DD</sub>		2.7	3.0	3.3	V
Output Supply Voltage	OV <sub>DD</sub>		1.8		V <sub>DD</sub>	V
		FD mode: $f_{CLK}$ = 45MHz, $f_{OUT}$ = 2.2MHz on both DAC channels; $f_{IN}$ = 5.5MHz on both ADC channels; aux- DACs ON and at midscale, aux-ADC ON		31.9	37	
		SPI2-Tx mode: $f_{CLK}$ = 45MHz, $f_{OUT}$ = 2.2MHz on both DAC channels; Rx ADC OFF; aux-DACs ON and at midscale, aux-ADC ON		16.7	19	
V <sub>DD</sub> Supply Current		SPI1-Rx mode: f <sub>CLK</sub> = 45MHz, f <sub>IN</sub> = 5.5MHz on both ADC channels; Tx DAC OFF (Tx DAC outputs at 0V); aux-DACs ON and at midscale, aux-ADC ON		27.6	32	mA
		SPI4-Tx mode: f <sub>CLK</sub> = 45MHz, f <sub>OUT</sub> = 2.2MHz on both DAC channels; Rx ADC ON (output three-stated); aux-DACs ON and at midscale, aux-ADC ON		31.0	36	
		SPI3-Rx mode: f <sub>CLK</sub> = 45MHz, f <sub>IN</sub> = 5.5MHz on both channels; Tx DAC ON (Tx DAC outputs at midscale); aux-DACs ON and at midscale, aux-ADC ON		30.2	35	
		Standby mode: CLK = 0 or OV <sub>DD</sub> ; aux-DACs ON and at midscale, aux-ADC ON		3.3	5	

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Electrical Characteristics (continued)**

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>DD</sub> Supply Current		Idle mode: f <sub>CLK</sub> = 45MHz; aux-DACs ON and at midscale, aux-ADC ON	12.4 15		15	mA
ADD Subbly carrent		Shutdown mode: CLK = 0 or OV <sub>DD</sub> , aux- ADC OFF		0.5	5	μA
		FD mode: $f_{CLK}$ = 45MHz, $f_{OUT}$ = 2.2MHz on both DAC channels; $f_{IN}$ = 5.5MHz on both ADC channels; aux-DACs ON and at midscale, aux-ADC ON		4.6		
OV <sub>DD</sub> Supply Current		SPI1-Rx and SPI3-Rx modes: f <sub>CLK</sub> = 45MHz, f <sub>IN</sub> = 5.5MHz on both ADC channels; DAC input bus three-stated; aux-DACs ON and at midscale, aux-ADC ON		4.35		mA
		SPI2-Tx and SPI4-Tx modes: f <sub>CLK</sub> = 45MHz, f <sub>OUT</sub> = 2.2MHz on both DAC channels; ADC output bus three-stated; aux-DACs ON and at midscale, aux-ADC ON		310		
		Standby mode: CLK = 0 or OV <sub>DD</sub> ; aux- DACs ON and at midscale, aux-ADC ON		0.1		μA
		Idle mode: f <sub>CLK</sub> = 45MHz; aux-DACs ON and at midscale, aux-ADC ON		73		
		Shutdown mode: CLK = 0 or OV <sub>DD</sub> , aux-ADC OFF		0.1		
Rx ADC DC ACCURACY						
Resolution			10			Bits
Integral Nonlinearity	INL			±1.25		LSB
Differential Nonlinearity	DNL			±0.65		LSB
Offset Error		Residual DC offset error	-5	±0.2	+5	%FS
Gain Error		Includes reference error	-5	±0.7	+5	%FS
DC Gain Matching			-0.15	±0.04	+0.15	dB
Offset Matching				±10		LSB
Gain Temperature Coefficient				±30		ppm/°C
Dower Cumply Deinsting		Offset (V <sub>DD</sub> ±5%)		±0.2		
Power-Supply Rejection		Gain (V <sub>DD</sub> ±5%)	±0.07		LSB	
Rx ADC ANALOG INPUT						
Input Differential Range	V <sub>ID</sub>	Differential or single-ended inputs	±0.512		V	
Input Common-Mode Voltage Range	V <sub>CM</sub>		V <sub>DD</sub> /2		V	
	R <sub>IN</sub>	Switched capacitor load		120		kΩ
Input Impedance	C <sub>IN</sub>			5		pF

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Electrical Characteristics (continued)**

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Rx ADC CONVERSION RATE						
Maximum Clock Frequency	fCLK	(Note 2)			45	MHz
		Channel IA		5		Clock
Data Latency		Channel QA		5.5		Cycles
<b>Rx ADC DYNAMIC CHARACTER</b>	ISTICS (Note 3	3)				1
		f <sub>IN</sub> = 5.5MHz	52.7	54.5		
Signal-to-Noise Ratio	SNR	f <sub>IN</sub> = 19.4MHz		54		dB
O'ment to Nation and D'stadian	01014.0	f <sub>IN</sub> = 5.5MHz	52.4	54.3		JD
Signal-to-Noise and Distortion	SINAD	f <sub>IN</sub> = 19.4MHz		53.9		dB
Spurious Eros Dynamia Banga	0500	f <sub>IN</sub> = 5.5MHz	63	72.1		dD a
Spurious-Free Dynamic Range	SFDR	f <sub>IN</sub> = 19.4MHz		76.3		- dBc
Total Harmonic Distortion	THD	f <sub>IN</sub> = 5.5MHz		-69.4	-61	dDo
		f <sub>IN</sub> = 19.4MHz		-71.3		dBc
Third Harmonia Distortion	1102	f <sub>IN</sub> = 5.5MHz		-73.7		dDe
Third-Harmonic Distortion	HD3	f <sub>IN</sub> = 19.4MHz		-76.3		dBc
Intermodulation Distortion	IMD	f <sub>IN1</sub> = 1.8MHz, A <sub>IN1</sub> = -7dBFS, f <sub>IN2</sub> = 1.0MHz, A <sub>IN2</sub> = -7dBFS		-69		dBc
Third-Order Intermodulation Distortion	IM3	f <sub>IN1</sub> = 1.8MHz, A <sub>IN1</sub> = -7dBFS, f <sub>IN2</sub> = 1.0MHz, A <sub>IN2</sub> = -7dBFS		-72		dBc
Aperture Delay				3.5		ns
Aperture Jitter				2		ps <sub>RMS</sub>
Overdrive Recovery Time		1.5x full-scale input		2		ns
Rx ADC INTERCHANNEL CHAR	ACTERISTICS		•			
Crosstalk Rejection		$      f_{INX,Y} = 5.5 \text{MHz}, A_{INX,Y} = -0.5 \text{dBFS}, \\       f_{INY,X} = 1.8 \text{MHz}, A_{INY,X} = -0.5 \text{Dbfs} \\       (Note 4) $		-88		dB
Amplitude Matching		f <sub>IN</sub> = 5.5MHz, A <sub>IN</sub> = -0.5dBFS (Note 5)		±0.02		dB
Phase Matching		f <sub>IN</sub> = 5.5MHz, A <sub>IN</sub> = -0.5dBFS (Note 5)		±0.03		Degrees
Tx DAC DC ACCURACY						
Resolution	N		10			Bits
Integral Nonlinearity	INL			±0.35		LSB
Differential Nonlinearity	DNL	Guaranteed monotonic (Note 6)	-0.7	±0.2	+0.7	LSB
Residual DC Offset	V <sub>OS</sub>		-4	±0.1	+4	mV
Full-Scale Gain Error			-40		+40	mV

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Electrical Characteristics (continued)**

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Tx DAC DYNAMIC PERFORMANC	E		1			1
DAC Conversion Rate	fCLK	(Note 2)			45	MHz
In-Band Noise Density	ND	f <sub>OUT</sub> = 2.2MHz		-129		dBFS/Hz
Third-Order Intermodulation Distortion	IM3	f <sub>OUT1</sub> = 2MHz, f <sub>OUT2</sub> = 2.2MHz		-82		dBc
Glitch Impulse				10		pV•s
Spurious-Free Dynamic Range to Nyquist	SFDR	f <sub>OUT</sub> = 2.2MHz	61.5	70.3		dBc
Total Harmonic Distortion to Nyquist	THD	f <sub>OUT</sub> = 2.2MHz		-68.1	-60.5	dBc
Signal-to-Noise Ratio to Nyquist	SNR	f <sub>OUT</sub> = 2.2MHz		56.1		dB
Tx DAC INTERCHANNEL CHARAG	CTERISTICS					
I-to-Q Output Isolation		f <sub>OUTX,Y</sub> = 500kHz, f <sub>OUTY,X</sub> = 620kHz		85		dB
Gain Mismatch Between I and Q Channels		Measured at DC	-0.4	±0.01	+0.4	dB
Phase Mismatch Between I and Q Channels		f <sub>OUT</sub> = 2.2MHz		±0.05		Degrees
Differential Output Impedance				800		Ω
Tx DAC ANALOG OUTPUT						
Full-Scale Output Voltage	V <sub>FS</sub>			±400		mV
	V <sub>COMD</sub>	Bits CM1 = 0, CM0 = 0 (default)	1.01	1.06	1.11	
Output Common-Mode Voltage		Bits CM1 = 0, CM0 = 1	0.88	0.94	1.00	v
Output Common-mode voltage		Bits CM1 = 1, CM0 = 0	0.75	0.82	0.90	
		Bits CM1 = 1, CM0 = 1	0.62	0.71	0.81	
Rx ADC-Tx DAC INTERCHANNEL	CHARACTE	ERISTICS				
Receive Transmit Isolation		ADC: f <sub>INI</sub> = f <sub>INQ</sub> = 5.5MHz, DAC: f <sub>OUTI</sub> = f <sub>OUTQ</sub> = 2.2MHz		85		dB
AUXILIARY ADCs (ADC1, ADC2)						
Resolution	N		10			Bits
Full-Scale Reference	\/	AD1 = 0 (default)		2.048		- v
	V <sub>REF</sub>	AD1 = 1		$V_{DD}$		v
Analog Input Range				0 to V <sub>REF</sub>		V
Analog Input Impedance		Measured at DC		500		kΩ
Input-Leakage Current		Measured at unselected input from 0 to V <sub>REF</sub>		±0.1		μΑ
Gain Error	GE	Includes reference error, AD1 = 0	-5		+5	%FS
Zero-Code Error	ZE			±2		mV
Differential Nonlinearity	DNL			±0.6		LSB

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Electrical Characteristics (continued)**

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Integral Nonlinearity	INL			±0.6		LSB
Supply Current				210		μA
AUXILIARY DACs (DAC1, DAC2, D	AC3)					
Resolution	Ν		12			Bits
Integral Nonlinearity	INL	From code 100 to code 4000		±1.25		LSB
Differential Nonlinearity	DNL	Guaranteed monotonic over code 100 to code 4000 (Note 6)	-1.0	±0.65	+1.2	LSB
Output-Voltage Low	V <sub>OL</sub>	R <sub>L</sub> > 200kΩ			0.2	V
Output-Voltage High	V <sub>OH</sub>	R <sub>L</sub> > 200kΩ	2.57			V
DC Output Impedance		DC output at midscale		4		Ω
Settling Time		From code 1024 to code 3072, within ±10 LSB		1		μs
Glitch Impulse		From code 0 to code 4095		24		nV•s
Rx ADC-Tx DAC TIMING CHARAC	TERISTICS					
CLK Rise to Channel-I Output Data Valid	t <sub>DOI</sub>	Figure 3 (Note 6)	5.5	8.2	12.5	ns
CLK Fall to Channel-Q Output Data Valid	t <sub>DOQ</sub>	Figure 3 (Note 6)	6.5	9.5	13.6	ns
I-DAC DATA to CLK Fall Setup Time	t <sub>DSI</sub>	Figure 5 (Note 6)	10			ns
Q-DAC DATA to CLK Rise Setup Time	t <sub>DSQ</sub>	Figure 5 (Note 6)	10			ns
CLK Fall to I-DAC Data Hold Time	t <sub>DHI</sub>	Figure 5 (Note 6)	0			ns
CLK Rise to Q-DAC Data Hold Time	t <sub>DHQ</sub>	Figure 5 (Note 6)	0			ns
CLK Duty Cycle				50		%
CLK Duty-Cycle Variation				±10		%
Digital Output Rise/Fall Time		20% to 80%		2.4		ns
SERIAL-INTERFACE TIMING CHA	RACTERISTI	CS (Figures 6 and 8, Note 6)				
Falling Edge of $\overline{\text{CS}}/\text{WAKE}$ to Rising Edge of First SCLK Time	tcss		10			ns
DIN to SCLK Setup Time	t <sub>DS</sub>		10			ns
DIN to SCLK Hold Time	t <sub>DH</sub>		0			ns
SCLK Pulse-Width High	tсн		25			ns
SCLK Pulse-Width Low	t <sub>CL</sub>		25			ns
SCLK Period	t <sub>CP</sub>		50			ns
SCLK to CS/WAKE Setup Time	t <sub>CS</sub>		10			ns
CS/WAKE High Pulse Width	t <sub>CSW</sub>		80			ns
CS/WAKE High to DOUT Active High	t <sub>CSD</sub>	Bit AD0 set		200		ns

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Electrical Characteristics (continued)**

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	
CS/WAKE High to DOUT Low (Aux-ADC Conversion Time)	<sup>t</sup> CONV	Bit AD0 set, no averaging, f <sub>CLK</sub> = 45MHz, CLK divider = 16		4.3		μs	
DOUT Low to $\overline{\text{CS}}$ /WAKE Setup Time	t <sub>DCS</sub>	Bit AD0, AD10 set		200		ns	
SCLK Low to DOUT Data Out	t <sub>CD</sub>	Bit AD0, AD10 set			14.5	ns	
CS/WAKE High to DOUT High Impedance	t <sub>CHZ</sub>	Bit AD0, AD10 set		200		ns	
MODE-RECOVERY TIMING CHAR	ACTERISTIC	S (Figure 7)					
		From shutdown to Rx mode, ADC settles to within 1dB SINAD		500			
		From shutdown to Tx mode, DAC settles to within 10 LSB error		26.4			
Shutdown Wake-Up Time	t <sub>WAKE,SD</sub>	From aux-ADC enable to aux-ADC start conversion		10		μs	
		From shutdown to aux-DAC output valid		28		]	
		From shutdown to FD mode, ADC settles to within 1dB SINAD, DAC settles to within 10 LSB error		500			
	<sup>t</sup> wake,sto	From idle to Rx mode with CLK present during idle, ADC settles to within 1dB SINAD		3.7			
Idle Wake-Up Time (With CLK)		From idle to Tx mode with CLK present during idle, DAC settles to 10 LSB error		5.1		μs	
		From idle to FD mode, ADC settles to within 1dB SINAD, DAC settles to within 10 LSB error		5.1			
		From standby to Rx mode, ADC settles to within 1dB SINAD		3.8			
Standby Wake-Up Time	twake,st1	From standby to Tx mode, DAC settles to 10 LSB error		24.4		μs	
	WARE, OTT	From standby to FD mode, ADC settles to within 1dB SINAD, DAC settles to within 10 LSB error		24.4			
Enable Time from Tx to Rx, Fast Mode	t <sub>ENABLE,RX</sub>	ADC settles to within 1dB SINAD		0.1		μs	
Enable Time from Rx to Tx, Fast Mode	t <sub>ENABLE,TX</sub>	DAC settles to within 10 LSB error 0.1			μs		
Enable Time from Tx to Rx, Slow Mode	t <sub>ENABLE,RX</sub>	ADC settles to within 1dB SINAD		3.7		μs	

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Electrical Characteristics (continued)**

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Enable Time from Rx to Tx, Slow Mode	t <sub>ENABLE,TX</sub>	DAC settles to within 10 LSB error		4.9		μs
INTERNAL REFERENCE (VREFIN =	= V <sub>DD</sub> ; V <sub>REFP</sub>	, V <sub>REFN</sub> , V <sub>COM</sub> levels are generated inte	rnally)			
Positive Reference		V <sub>REFP</sub> - V <sub>COM</sub>		0.256		V
Negative Reference		V <sub>REFN</sub> - V <sub>COM</sub>		-0.256		V
Common-Mode Output Voltage	V <sub>COM</sub>		V <sub>DD</sub> /2 - 0.15	V <sub>DD</sub> /2	V <sub>DD</sub> /2 + 0.15	V
Maximum REFP/REFN/COM Source Current	ISOURCE			2		mA
Maximum REFP/REFN/COM Sink Current	ISINK			2		mA
Differential Reference Output	V <sub>REF</sub>	V <sub>REFP</sub> - V <sub>REFN</sub>	+0.490	+0.512	+0.534	V
Differential Reference Temperature Coefficient	REFTC			±30		ppm/°C
BUFFERED EXTERNAL REFEREN	CE (external	V <sub>REFIN</sub> = 1.024V applied; V <sub>REFP</sub> , V <sub>REFN</sub> , V	/ <sub>COM</sub> level	s are ger	nerated in	ternally)
Reference Input Voltage	V <sub>REFIN</sub>			1.024		V
Differential Reference Output	V <sub>DIFF</sub>	V <sub>REFP</sub> - V <sub>REFN</sub>		0.512		V
Common-Mode Output Voltage	V <sub>COM</sub>			V <sub>DD</sub> /2		V
Maximum REFP/REFN/COM Source Current	ISOURCE			2		mA
Maximum REFP/REFN/COM Sink Current	I <sub>SINK</sub>			2		mA
REFIN Input Current				-0.7		μA
REFIN Input Resistance				500		kΩ
DIGITAL INPUTS (CLK, SCLK, DIN	, CS/WAKE,	DA9–DA0)				
Input High Threshold	V <sub>INH</sub>		0.7 x OV	DD		V
Input Low Threshold	V <sub>INL</sub>			0.3	x OV <sub>DD</sub>	V
		CLK, SCLK, DIN, $\overline{CS}$ /WAKE = OGND or OV <sub>DD</sub>	-1		+1	
Input Leakage	DI <sub>IN</sub>	DA9–DA0 = OV <sub>DD</sub>	-1		+1	μA
		DA9–DA0 = OGND	-5		+5	
Input Capacitance	DCIN			5		pF
DIGITAL OUTPUTS (AD9-AD0, DC	OUT)					
Output-Voltage Low	V <sub>OL</sub>	I <sub>SINK</sub> = 200μA		0.2	x OV <sub>DD</sub>	V
Output-Voltage High	V <sub>OH</sub>	I <sub>SOURCE</sub> = 200µA	0.8 x OV	DD		V
Tri-State Leakage Current	ILEAK		-1		+1	μA
Tri-State Output Capacitance	C <sub>OUT</sub>			5		pF

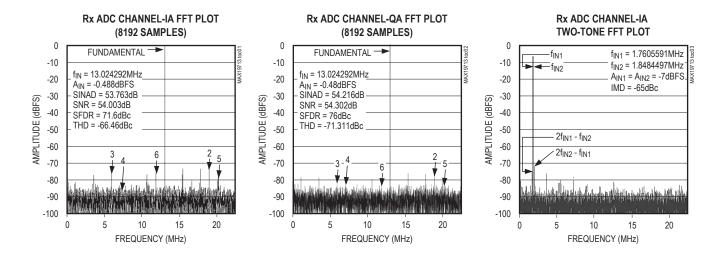
## **Electrical Characteristics (continued)**

 $(V_{DD} = 3V, OV_{DD} = 1.8V)$ , internal reference (1.024V),  $C_L \approx 10pF$  on all digital outputs,  $f_{CLK} = 45MHz$  (50% duty cycle), Rx ADC input amplitude = -0.5dBFS, Tx DAC output amplitude = 0dBFS, CM1 = 0, CM0 = 0, differential Rx ADC input, differential Tx DAC output,  $C_{REFP} = C_{REFN} = C_{COM} = 0.33\muF$ ,  $C_L < 5pF$  on all aux-DAC outputs,  $T_A = T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted. Typical values are at  $T_A = +25^{\circ}C$ .) (Note 1)

- Note 1: Specifications from T<sub>A</sub> = +25°C to +85°C guaranteed by production tests. Specifications at T<sub>A</sub> < +25°C guaranteed by design and characterization.
- **Note 2:** The minimum clock frequency ( $f_{CLK}$ ) for the MAX19713 is 7.5MHz (typ). The minimum aux-ADC sample rate clock frequency ( $A_{CLK}$ ) is determined by  $f_{CLK}$  and the chosen aux-ADC clock-divider value. The minimum aux-ADC  $A_{CLK}$  > 7.5MHz / 128 = 58.6kHz. The aux-ADC conversion time does not include the time to clock the serial data out of DOUT. The maximum conversion time (for no averaging, NAVG = 1) will be  $t_{CONV}$  (max) = (12 x 1 x 128) / 7.5MHz = 205µs.
- **Note 3:** SNR, SINAD, SFDR, HD3, and THD are based on a differential analog input voltage of -0.5dBFS referenced to the amplitude of the digital outputs. SINAD and THD are calculated using HD2 through HD6.
- **Note 4:** Crosstalk rejection is measured by applying a high-frequency test tone to one channel and a low-frequency tone to the second channel. FFTs are performed on each channel. The parameter is specified as the power ratio of the first and second channel FFT test tones.
- **Note 5:** Amplitude and phase matching are measured by applying the same signal to each channel, and comparing the two output signals using a sine-wave fit.
- Note 6: Guaranteed by design and characterization.

### **Typical Operating Characteristics**

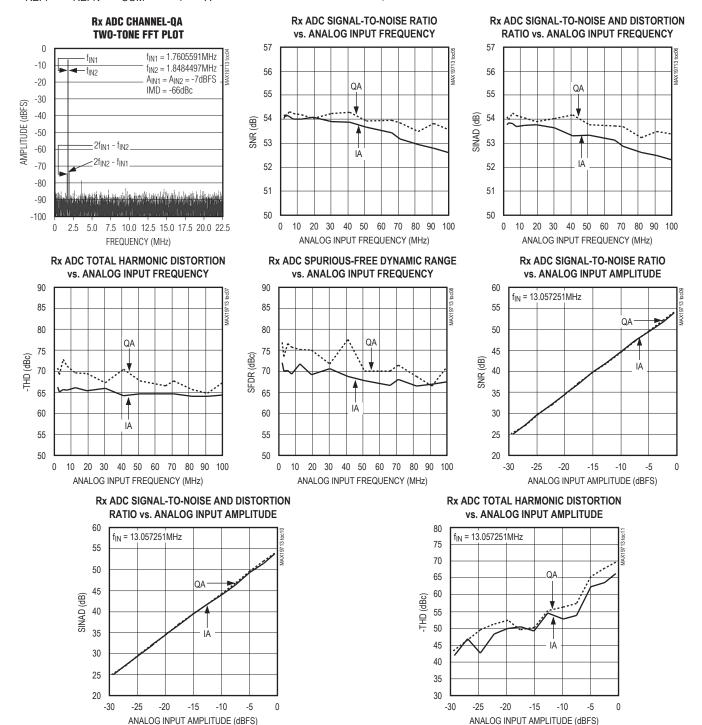
 $(V_{DD} = 3V, OV_{DD} = 1.8V)$ , internal reference (1.024V),  $C_L \approx 10$ pF on all digital outputs,  $f_{CLK} = 45$ MHz (50% duty cycle), Rx ADC input amplitude = -0.5dBFS, Tx DAC output amplitude = 0dBFS, CM1 = 0, CM0 = 0, differential Rx ADC input, differential Tx DAC output,  $C_{REFP} = C_{REFN} = C_{COM} = 0.33\mu$ F,  $T_A = +25^{\circ}$ C, unless otherwise noted.)



# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Typical Operating Characteristics (continued)**

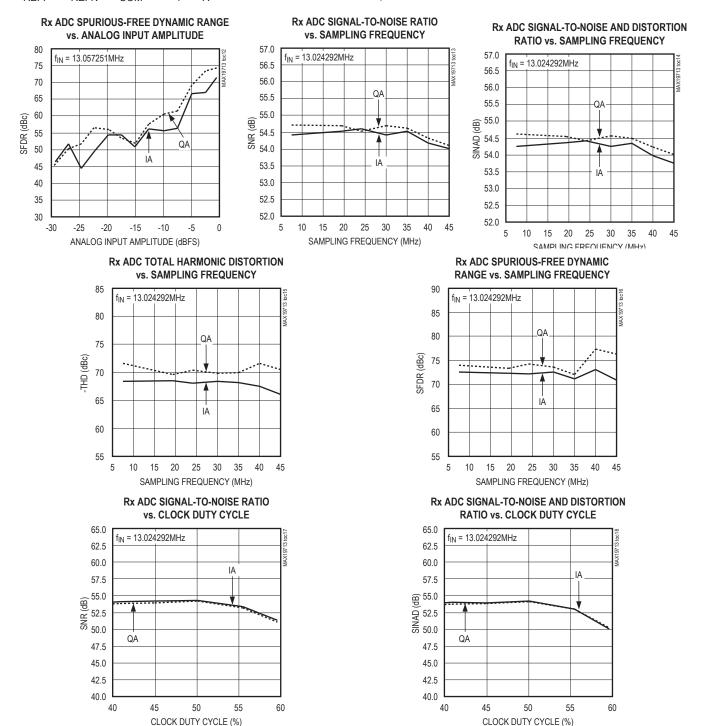
 $(V_{DD} = 3V, OV_{DD} = 1.8V, internal reference (1.024V), C_L \approx 10pF on all digital outputs, f_{CLK} = 45MHz (50% duty cycle), Rx ADC input amplitude = -0.5dBFS, Tx DAC output amplitude = 0dBFS, CM1 = 0, CM0 = 0, differential Rx ADC input, differential Tx DAC output, C_{REFP} = C_{REFN} = C_{COM} = 0.33\mu$ F, T<sub>A</sub> = +25°C, unless otherwise noted.)



# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Typical Operating Characteristics (continued)**

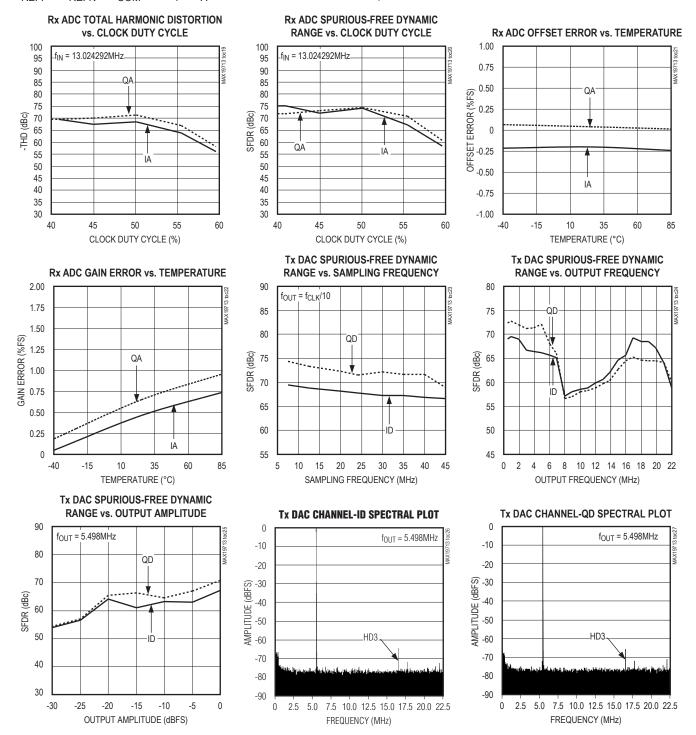
 $(V_{DD} = 3V, OV_{DD} = 1.8V)$ , internal reference (1.024V),  $C_L \approx 10$ pF on all digital outputs,  $f_{CLK} = 45$ MHz (50% duty cycle), Rx ADC input amplitude = -0.5dBFS, Tx DAC output amplitude = 0dBFS, CM1 = 0, CM0 = 0, differential Rx ADC input, differential Tx DAC output,  $C_{REFP} = C_{REFN} = C_{COM} = 0.33\mu$ F,  $T_A = +25^{\circ}$ C, unless otherwise noted.)



# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Typical Operating Characteristics (continued)**

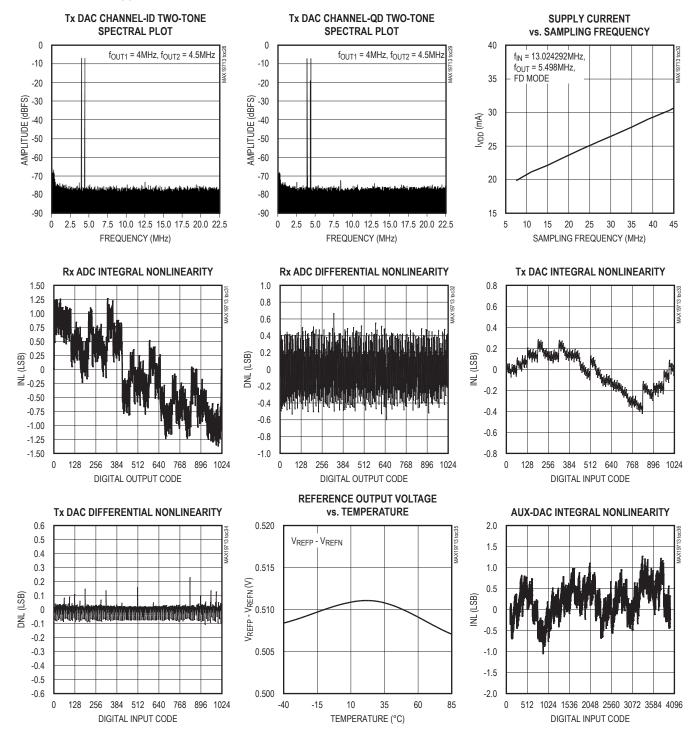
 $(V_{DD} = 3V, OV_{DD} = 1.8V, internal reference (1.024V), C_L \approx 10pF on all digital outputs, f_{CLK} = 45MHz (50% duty cycle), Rx ADC input amplitude = -0.5dBFS, Tx DAC output amplitude = 0dBFS, CM1 = 0, CM0 = 0, differential Rx ADC input, differential Tx DAC output, C_{REFP} = C_{REFN} = C_{COM} = 0.33\mu$ F, T<sub>A</sub> = +25°C, unless otherwise noted.)



# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Typical Operating Characteristics (continued)**

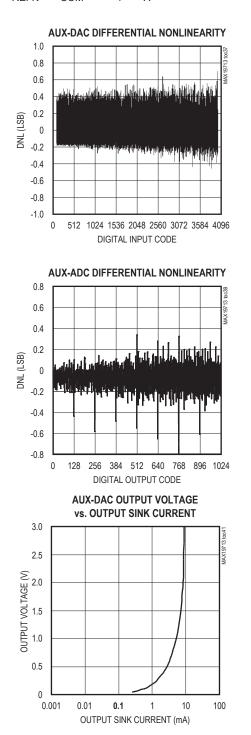
 $(V_{DD} = 3V, OV_{DD} = 1.8V, internal reference (1.024V), C_L \approx 10pF on all digital outputs, f_{CLK} = 45MHz (50% duty cycle), Rx ADC input amplitude = -0.5dBFS, Tx DAC output amplitude = 0dBFS, CM1 = 0, CM0 = 0, differential Rx ADC input, differential Tx DAC output, C_{REFP} = C_{REFN} = C_{COM} = 0.33\mu$ F, T<sub>A</sub> = +25°C, unless otherwise noted.)

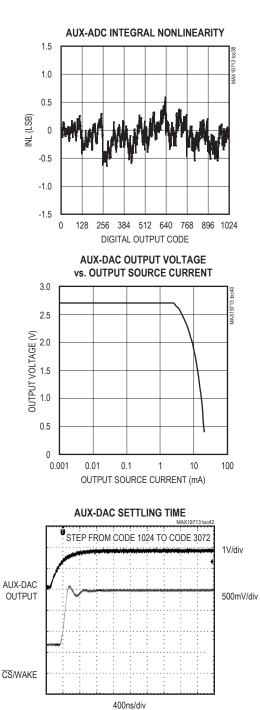


# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Typical Operating Characteristics (continued)**

 $(V_{DD} = 3V, OV_{DD} = 1.8V, internal reference (1.024V), C_L \approx 10pF$  on all digital outputs,  $f_{CLK} = 45MHz$  (50% duty cycle), Rx ADC input amplitude = 0.05dBFS, Tx DAC output amplitude = 0.05dBFS, CM1 = 0, CM0 = 0, differential Rx ADC input, differential Tx DAC output,  $C_{REFP} = C_{REFN} = C_{COM} = 0.33\mu$ F,  $T_A = +25^{\circ}$ C, unless otherwise noted.)





# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Pin Description**

PIN	NAME	FUNCTION
1	REFP	Positive Reference Voltage Input Terminal. Bypass with a $0.33\mu$ F capacitor to GND as close as possible to REFP.
2, 8, 11, 39, 41, 47, 51	V <sub>DD</sub>	Analog Supply Voltage. Bypass $V_{DD}$ to GND with a combination of a 2.2µF capacitor in parallel with a 0.1µF capacitor.
3	IAP	Channel-IA Positive Analog Input. For single-ended operation, connect signal source to IAP.
4	IAN	Channel-IA Negative Analog Input. For single-ended operation, connect IAN to COM.
5, 7, 12, 40, 50	GND	Analog Ground. Connect all GND pins to ground plane.
6	CLK	Conversion Clock Input. Clock signal for both receive ADCs and transmit DACs.
9	QAN	Channel-QA Negative Analog Input. For single-ended operation, connect QAN to COM.
10	QAP	Channel-QA Positive Analog Input. For single-ended operation, connect signal source to QAP.
13–22	AD0–AD9	Receive ADC Digital Outputs. AD9 is the most significant bit (MSB) and AD0 is the least significant bit (LSB).
23	OGND	Output-Driver Ground
24	OV <sub>DD</sub>	Output-Driver Power Supply. Supply range from +1.8V to $V_{DD}$ . Bypass $OV_{DD}$ to OGND with a combination of a 2.2µF capacitor in parallel with a 0.1µF capacitor.
25–34	DA0–DA9	Transmit DAC Digital Inputs. DA9 is the most significant bit (MSB) and DA0 is the least significant bit (LSB). DA0–DA9 are internally pulled up to $OV_{DD}$ .
35	DOUT	Aux-ADC Digital Output
36	DIN	3-Wire Serial-Interface Data Input. Data is latched on the rising edge of SCLK.
37	SCLK	3-Wire Serial-Interface Clock Input
38	CS/WAKE	3-Wire Serial-Interface Chip-Select/WAKE Input. When the MAX19713 is in shutdown, $\overline{CS}$ /WAKE controls the wake-up function. See the <i>Wake-Up Function</i> section.
42	ADC2	Selectable Auxiliary ADC Analog Input 2
43	ADC1	Selectable Auxiliary ADC Analog Input 1
44	DAC3	Auxiliary DAC3 Analog Output (V <sub>OUT</sub> = 0 at Power-Up)
45	DAC2	Auxiliary DAC2 Analog Output (V <sub>OUT</sub> = 0 at Power-Up)
46	DAC1	Auxiliary DAC1 Analog Output (AFC DAC, V <sub>OUT</sub> = 1.1V at Power-Up)
48	IDN	Tx DAC Channel-ID Differential Negative Output
49	IDP	Tx DAC Channel-ID Differential Positive Output
52	QDN	Tx DAC Channel-QD Differential Negative Output
53	QDP	Tx DAC Channel-QD Differential Positive Output
54	REFIN	Reference Input. Connect to V <sub>DD</sub> for internal reference.
55	COM	Common-Mode Voltage I/O. Bypass COM to GND with a 0.33µF capacitor.
56	REFN	Negative Reference Voltage Input Terminal. Rx ADC conversion range is $\pm(V_{REFP} - V_{REFN})$ . Bypass REFN to GND with a 0.33µF capacitor.
—	EP	Exposed Paddle. Internally connected to GND. Connect EP to the GND plane.

## **Detailed Description**

The MAX19713 integrates a dual, 10-bit Rx ADC and a dual, 10-bit Tx DAC while providing ultra-low power and high dynamic performance at 45Msps conversion rate.

The Rx ADC analog input amplifiers are fully differential and accept 1.024V<sub>P-P</sub> full-scale signals. The Tx DAC analog outputs are fully differential with ±400mV full-scale output, selectable common-mode DC level, and adjustable channel ID–QD offset trim.

The MAX19713 integrates three 12-bit auxiliary DACs (aux-DACs) and a 10-bit, 333ksps auxiliary ADC (aux-ADC) with 4:1 input multiplexer. The aux-DAC channels feature 1µs settling time for fast AGC, VGA, and AFC level setting. The aux-ADC features data averaging to reduce processor overhead and a selectable clock-divider to program the conversion rate.

The MAX19713 includes a 3-wire serial interface to control operating modes and power management. The serial interface is SPI and MICROWIRE compatible. The MAX19713 serial interface selects shutdown, idle, standby, FD, transmit (Tx), and receive (Rx) modes, as well as controls aux-DAC and aux-ADC channels.

The MAX19713 features two independent, high-speed, 10-bit buses for the Rx ADC and Tx DAC, which allow full-duplex (FD) operation for frequency-division duplex applications. Each bus can be disabled to optimize power management through the 3-wire interface. The MAX19713

operates from a single 2.7V to 3.3V analog supply and a 1.8V to 3.3V digital supply.

#### Dual 10-Bit Rx ADC

The ADC uses a seven-stage, fully differential, pipelined architecture that allows for high-speed conversion while minimizing power consumption. Samples taken at the inputs move progressively through the pipeline stages every half clock cycle. Including the delay through the output latch, the total clock-cycle latency is 5 clock cycles for channel IA and 5.5 clock cycles for channel QA. The ADC full-scale analog input range is  $\pm V_{REF}$  with a  $V_{DD}/2$  ( $\pm 0.8V$ ) common-mode input range.  $V_{REF}$  is the difference between  $V_{REFP}$  and  $V_{REFN}$ . See the *Reference Configurations* section for details.

#### Input Track-and-Hold (T/H) Circuits

Figure 1 displays a simplified diagram of the Rx ADC input track-and-hold (T/H) circuitry. Both ADC inputs (IAP, QAP, IAN, and QAN) can be driven either differentially or single-ended. Match the impedance of IAP and IAN, as

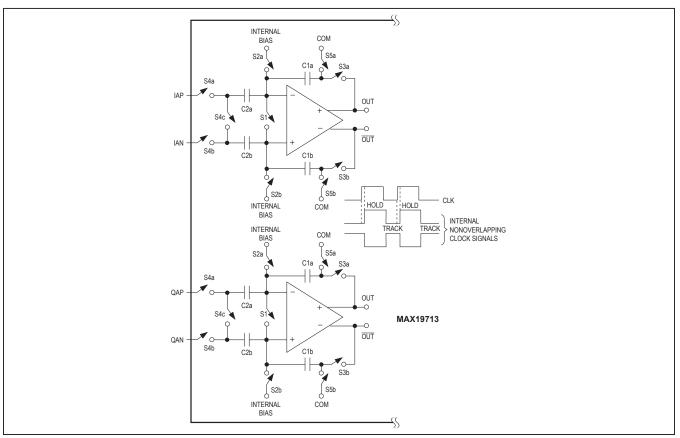


Figure 1. Rx ADC Internal T/H Circuits

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

DIFFERENTIAL INPUT VOLTAGE	DIFFERENTIAL INPUT (LSB)	OFFSET BINARY (AD0-AD9)	OUTPUT DECIMAL CODE
V <sub>REF</sub> x 512/512	511 (+Full Scale - 1 LSB)	11 1111 1111	1023
V <sub>REF</sub> x 511/512	510 (+Full Scale - 2 LSB)	11 1111 1110	1022
V <sub>REF</sub> x 1/512	+1	10 0000 0001	513
V <sub>REF</sub> x 0/512	0 (Bipolar Zero)	10 0000 0000	512
-V <sub>REF</sub> x 1/512	-1	01 1111 1111	511
-V <sub>REF</sub> x 511/512	-511 (-Full Scale + 1 LSB)	00 0000 0001	1
-V <sub>REF</sub> x 512/512	-512 (-Full Scale)	00 0000 0000	0

#### Table 1. Rx ADC Output Codes vs. Input Voltage

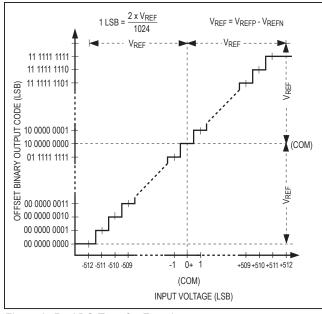


Figure 2. Rx ADC Transfer Function

well as QAP and QAN, and set the input signal commonmode voltage within the V\_DD/2 (±0.8V) Rx ADC range for optimum performance.

#### **Rx ADC System Timing Requirements**

Figure 3 shows the relationship between the clock, analog inputs, and the resulting output data. Channels IA and QA are sampled on the rising edge of the clock signal (CLK) and the resulting data is multiplexed at the AD0–AD9 outputs. Channel IA data is updated on the rising edge and channel QA data is updated on the falling edge of

CLK. Including the delay through the output latch, the total clock-cycle latency is 5 clock cycles for channel IA and 5.5 clock cycles for channel QA.

#### Digital Output Data (AD0-AD9)

AD0–AD9 are the Rx ADC digital logic outputs of the MAX19713. The logic level is set by  $OV_{DD}$  from 1.8V to  $V_{DD}$ . The digital output coding is offset binary (Table 1). Keep the capacitive load on the digital outputs AD0–AD9 as low as possible (< 15pF) to avoid large digital currents feeding back into the analog portion of the MAX19713 and degrading its dynamic performance. Buffers on the digital outputs isolate the outputs from heavy capacitive loads. Adding 100 $\Omega$  resistors in series with the digital outputs close to the MAX19713 will help improve ADC performance. Refer to the MAX19713 EV kit schematic for an example of the digital outputs driving a digital buffer through 100 $\Omega$  series resistors.

During SHDN, IDLE, STBY, SPI2, and SPI4 states, digital outputs AD0–AD9 are three-stated.

### **Dual 10-Bit Tx DACs**

The dual 10-bit digital-to-analog converters (Tx DACs) operate with clock speeds up to 45MHz. The Tx DAC digital inputs, DA0–DA9, are multiplexed on a single 10-bit transmit bus. The voltage reference determines the Tx DAC full-scale voltage at IDP, IDN and QDP, QDN analog outputs. See the <u>Reference Configurations</u> section for setting the reference voltage.

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

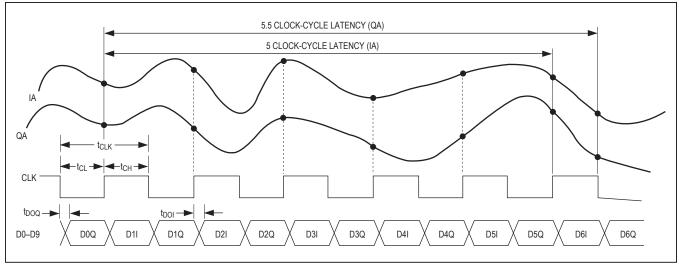


Figure 3. Rx ADC System Timing Diagram

### Table 2. Tx DAC Output Voltage vs. Input Codes

(Internal Reference Mode V<sub>REFDAC</sub> = 1.024V, External Reference Mode V<sub>REFDAC</sub> = V<sub>REFIN</sub>, V<sub>FS</sub> = 400 for 800mV<sub>P-P</sub> Full Scale)

DIFFERENTIAL OUTPUT VOLTAGE (V)	OFFSET BINARY (DA0-DA9)	INPUT DECIMAL CODE
$(V_{FS})\frac{V_{REFDAC}}{1024} \times \frac{1023}{1023}$	11 1111 1111	1023
$(V_{FS})\frac{V_{REFDAC}}{1024} \times \frac{1021}{1023}$	11 1111 1110	1022
$(V_{FS}) \frac{V_{REFDAC}}{1024} \times \frac{3}{1023}$	10 0000 0001	513
$(V_{FS}) \frac{V_{REFDAC}}{1024} \times \frac{1}{1023}$	10 0000 0000	512
$(V_{FS}) \frac{-V_{REFDAC}}{1024} \times \frac{1}{1023}$	01 1111 1111	511
$(V_{FS}) \frac{-V_{REFDAC}}{1024} \times \frac{1021}{1023}$	00 0000 0001	1
$(V_{FS}) \frac{-V_{REFDAC}}{1024} \times \frac{1023}{1023}$	00 0000 0000	0

The Tx DAC outputs (IDN, IDP, QDN, QDP) are biased at an adjustable common-mode DC level and designed to drive a differential input stage with  $\geq$  70k $\Omega$  input impedance. This simplifies the analog interface between RF quadrature upconverters and the MAX19713. Many RF upconverters require a 0.71V to 1.06V common-mode bias. The MAX19713 common-mode DC bias eliminates discrete level-setting resistors and code-generated level shifting while preserving the full dynamic range of each Tx DAC. The Tx DAC differential analog outputs cannot be used in single-ended mode because of the internally generated common-mode DC level. <u>Table 2</u> shows the Tx DAC output voltage vs. input codes. <u>Table 10</u> shows the selection of DC common-mode levels.

See <u>Table 4</u> for an illustration of the Tx DAC analog output levels. The Tx DAC also features an independent DC offset trim on each ID–QD channel. This feature is configured through the SPI interface. The DC offset correction is used to optimize sideband and carrier suppression in the Tx signal path (see Table 9).

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

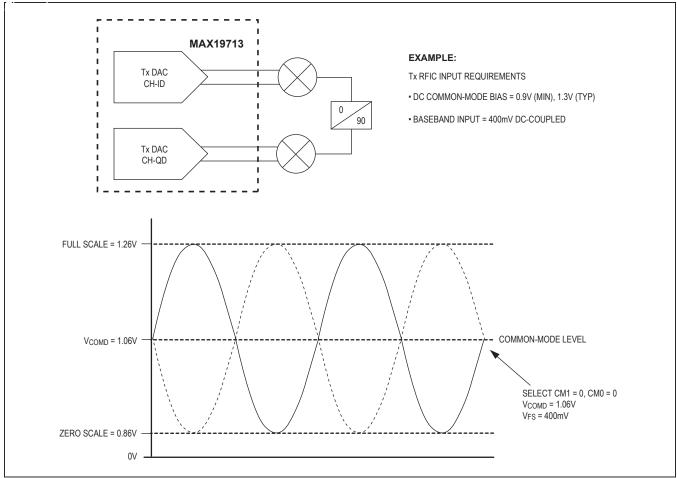


Figure 4. Tx DAC Common-Mode DC Level at IDN, IDP or QDN, QDP Differential Outputs

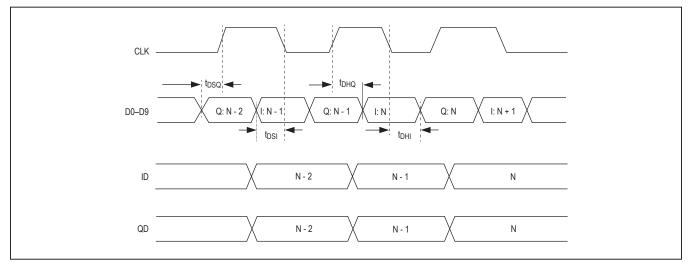


Figure 5. Tx DAC System Timing Diagram

#### **Tx DAC Timing**

Figure 5 shows the relationship among the clock, input data, and analog outputs. Channel ID data is latched on the falling edge of the clock signal, and channel QD data is latched on the rising edge of the clock signal, at which point both ID and QD outputs are simultaneously updated.

# 3-Wire Serial Interface and Operation Modes

The 3-wire serial interface controls the MAX19713 operation modes as well as the three 12-bit aux-DACs and the 10-bit aux-ADC. Upon power-up, program the MAX19713 to operate in the desired mode. Use the 3-wire serial interface to program the device for shutdown, idle, standby, FD, Rx, Tx, aux-DAC controls, or aux-ADC conversion. A 16-bit data register sets the mode control as shown in <u>Table 3</u>. The 16-bit word is composed of four control bits (A3–A0) and 12 data bits (D11–D0). Data is shifted in MSB first (D11) and LSB last (A0) format. <u>Table 4</u> shows the MAX19713 power-management modes. <u>Table 5</u> shows the SPI-controlled Tx, Rx, and FD modes. The serial interface remains active in all modes.

#### **SPI Register Description**

Program the control bits, A3–A0, in the register as shown in <u>Table 3</u> to select the operating mode. Modify A3–A0 bits to select from ENABLE-16, Aux-DAC1, Aux-DAC2, Aux-DAC3, IOFFSET, QOFFSET, COMSEL, Aux-ADC, ENABLE-8, and WAKEUP-SEL modes. ENABLE-16 is the default operating mode (<u>Table 6</u>). This mode allows for shutdown, idle, and standby states as well as switching between FAST, SLOW, Rx and Tx modes. <u>Table 4</u> and Table 5 show the required SPI settings for each mode.

In ENABLE-16 mode, the aux-DACs have independent control bits E4, E5, and E6, bit E9 enables the aux-ADC. <u>Table 7</u> shows the auxiliary DAC enable codes. <u>Table 8</u> shows the auxiliary ADC enable code. Bits E11 and E10 are reserved. Program bits E11 and E10 to logic-low. Bits E3, E7, and E8 are not used.

Modes aux-DAC1, aux-DAC2, and aux-DAC3 select the aux-DAC channels named DAC1, DAC2, and DAC3 and hold the data inputs for each DAC. Bits \_D11–\_D0 are the data inputs for each aux-DAC and can be programmed through SPI. The MAX19713 also includes two 6-bit registers that can be programmed to adjust the offsets for the Tx DAC ID and QD channels independently (see Table 9). Use the COMSEL mode to select the output common-mode voltage with bits CM1 and CM0 (Table 10). Use aux-ADC mode to start the auxiliary ADC conversion (see the <u>10-Bit, 333ksps Auxiliary ADC</u> section for details). Use ENABLE-8 mode for faster enable and switching

between shutdown, idle, and standby states as well as switching between FAST, SLOW, Rx and Tx modes and the FD mode.

The WAKEUP-SEL register selects the operating mode that the MAX19713 is to enter immediately after coming out of shutdown (<u>Table 11</u>). See the <u>Wake-Up Function</u> section for more information.

Shutdown mode offers the most dramatic power savings by shutting down all the analog sections (including the reference) of the MAX19713. In shutdown mode, the Rx ADC digital outputs are in three-state mode, the Tx DAC digital inputs are internally pulled to  $OV_{DD}$ , and the Tx DAC outputs are at 0V. When the Rx ADC outputs transition from three-state to active mode, the last converted word is placed on the digital output bus. The Tx DAC previously stored data is lost when coming out of shutdown mode. The wake-up time from shutdown mode is dominated by the time required to charge the capacitors at REFP, REFN, and COM. In internal reference mode and buffered external reference mode, the wake-up time is typically 500µs to enter Rx mode, 26.4µs to enter Tx mode, and 500µs to enter FD mode.

In all operating modes, the Tx DAC inputs DA0–DA9 are internally pulled to  $OV_{DD}$ . To reduce the supply current of the MAX19713 in shutdown mode do not pull DA0–DA9 low. This consideration is especially important in shutdown mode to achieve the lowest quiescent current.

In idle mode, the reference and clock distribution circuits are powered, but all other functions are off. The Rx ADC outputs AD0–AD9 are forced to three-state. The Tx DAC DA0–DA9 inputs are internally pulled to  $OV_{DD}$ , while the Tx DAC outputs are at 0V. The wake-up time is 3.7µs to enter Rx mode, 5.1µs to enter Tx mode, and 5.1µs to enter FD mode. When the Rx ADC outputs transition from three-state to active, the last converted word is placed on the digital output bus.

In standby mode, the reference is powered but all other device functions are off. The wake-up time from standby mode is  $3.8\mu$ s to enter Rx mode,  $24.4\mu$ s to enter Tx mode, and  $24.4\mu$ s to enter FD mode. When the Rx ADC outputs transition from three-state to active, the last converted word is placed on the digital output bus.

#### FAST and SLOW Rx and Tx Modes

The MAX19713 features FAST and SLOW modes for switching between Rx and Tx operation. In FAST Tx mode, the Rx ADC core is powered on but the ADC digital outputs AD0–AD9 are three-stated. The Tx DAC digital bus is active and the DAC core is fully operational.

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REGISTER	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	A3	A2	A1	A0
NAME	(MSB)	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1 (LSB)
ENABLE-16	E11 = 0 Reserved	E10 = 0 Reserved	E9	_	_	E6	E5	E4	_	E2	E1	E0	0	0	0	0
Aux-DAC1	1D11	1D10	1D9	1D8	1D7	1D6	1D5	1D4	1D3	1D2	1D1	1D0	0	0	0	1
Aux-DAC2	2D11	2D10	2D9	2D8	2D7	2D6	2D5	2D4	2D3	2D2	2D1	2D0	0	0	1	0
Aux-DAC3	3D11	3D10	3D9	3D8	3D7	3D6	3D5	3D4	3D3	3D2	3D1	3D0	0	0	1	1
IOFFSET	_	—	_	_	_	_	105	104	103	102	IO1	100	0	1	0	0
QOFFSET	—	—	—	_	_	_	QO5	QO4	QO3	QO2	QO1	QO0	0	1	0	1
COMSEL	_	—	_		_	_	_	_	_	—	CM1	CM0	0	1	1	0
Aux-ADC	AD11 = 0 Reserved	AD10	AD9	AD8	AD7	AD6	AD5	AD4	AD3	AD2	AD1	AD0	0	1	1	1
ENABLE-8	_	—	_		—	_	_	_	_	E2	E1	E0	1	0	0	0
WAKEUP-SEL	—	—	—		—	—	—	—	_	W2	W1	W0	1	0	0	1

## Table 3. MAX19713 Mode Control

— = Not used.

## Table 4. Power-Management Modes

	ADD	RESS			DATA	BITS		MODE	FUNCTION (POWER	DESCRIPTION	COMMENT
A3	A2	A1	A0	E9*	E2	E1	E0	WIODE	MANAGEMENT)	DESCRIPTION	COMINENT
			1	0	0	0	SHDN	SHUTDOWN	Rx ADC = OFF Tx DAC = OFF (TX DAC outputs at 0V) Aux-DAC = OFF Aux-ADC = OFF CLK = OFF REF = OFF	Device is in complete shutdown.	
	0000 (16-Bit Mode) or 1000 (8-Bit Mode)		X**	0	0	1	IDLE	IDLE	Rx ADC = OFF Tx DAC = OFF (TX DAC outputs at 0V) Aux-DAC = Last State CLK = ON REF = ON	Fast turn-on time. Moderate idle power.	
	X*1		X**	0	1	0	STBY	STANDBY	Rx ADC = OFF Tx DAC = OFF (TX DAC outputs at 0V) Aux-DAC = Last State CLK = OFF REF = ON	Slow turn-on time. Low standby power.	

X = Don't care.

\*Bit E9 is not available in 8-bit mode.

\*\*In IDLE and STBY modes, the aux-ADC can be turned on or off.

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	ADDI	RESS		DA	TA BI	TS	MODE	FUNCTION	DESCRIPTION	COMMENT
A3	A2	A1	A0	E2	E1	E0	WODE	(Tx-Rx SWITCHING SPEED)	DESCRIPTION	COMINIENT
	0000 (16-Bit Mode) and 1000 (8-Bit Mode)			0	1	1	SPI1-Rx	SLOW	Rx Mode: Rx ADC = ON Rx Bus = Enabled Tx DAC = OFF (Tx DAC outputs at 0V) Tx Bus = OFF (all inputs are pulled high)	Slow transition to Tx mode from this mode. Low power.
			1 0 0		0	SPI2-Tx	SLOW	Tx Mode: Rx ADC = OFF Rx Bus = Tri-state Tx DAC = ON Tx Bus = ON	Slow transition to Rx mode from this mode. Low power.	
			1	0	1	SPI3-Rx	FAST	Rx Mode: Rx ADC = ON Rx Bus = Enabled Tx DAC = ON (Tx DAC outputs at midscale) Tx Bus = OFF (all inputs are pulled high)	Fast transition to Tx mode from this mode. Moderate power.	
			1	1	0	SPI4-Tx	FAST	Tx Mode: Rx ADC = ON Rx Bus = Tri-state Tx DAC = ON Tx Bus = ON	Fast transition to Rx mode from this mode. Moderate power.	
				1	1	1	FD	FAST	FD Mode: Rx ADC = ON Rx Bus = ON Tx DAC = ON Tx Bus = ON	<b>Default Mode</b> Fast transition to any mode. Moderate power.

## Table 5. MAX19713 Tx, Rx, and FD Control Using SPI Commands

In FAST Rx mode, the Tx DAC core is powered on. The Tx DAC outputs are set to midscale. In this mode, the Tx DAC input bus is disconnected from the DAC core and DA0–DA9 are internally pulled to OV<sub>DD</sub>. The Rx ADC digital bus is active and the ADC core is fully operational.

In FAST mode, the switching time from Tx to Rx, or Rx to Tx is minimized because the converters are on and do not have to recover from a power-down state. In FAST mode, the switching time from Rx to Tx and Tx to Rx is 0.1µs. Power consumption is higher in FAST mode because both Tx and Rx cores are always on.

In SLOW Tx mode, the Rx ADC core is powered off and the ADC digital outputs AD0–AD9 are three-stated. The

Tx DAC digital bus is active and the DAC core is fully operational. In SLOW Rx mode, the Tx DAC core is powered off. The Tx DAC outputs are set to 0. In SLOW Rx mode, the Tx DAC input bus is disconnected from the DAC core and DA0–DA9 are internally pulled to  $OV_{DD}$ . The Rx ADC digital bus is active and the ADC core is fully operational. The switching times for SLOW modes are 4.9µs for Rx to Tx and 3.7µs for Tx to Rx.

Power consumption in SLOW Tx mode is 49.5mW, and 79.2mW in SLOW Rx mode. Power consumption in FAST Tx mode is 89.1mW, and 86.4mW in FAST Rx mode.

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

					· · ·							
	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
REGISTER NAME	16 (MSB)	15	14	13	12	11	10	9	8	7	6	5
			0			0	0	0		1	1	1
ENABLE-16	0	0	Aux-ADC = ON	—	_	Aux-DA	C1 to Aux- ON	DAC3 =	_		FD mode	
Aux-DAC1	0	1	1	0	1	0	0	0	1	1	0	0
Aux-DACT					DA	AC1 outpu	it set to 1.	1V				
Aux-DAC2	0	0	0	0	0	0	0	0	0	0	0	0
Aux-DAC2		DAC2 output set to 0V										
Aux-DAC3	0	0	0	0	0	0	0	0	0	0	0	0
		DAC3 output set to 0V										
IOFFSET	_	_	_			_	0	0	0	0	0	0
							No offset on channel ID					
QOFFSET	_	_	_	_	_	_	0	0	0	0	0	0
								No	offset on	channel (	ΩD	
COMSEL	_		_	_	_	_	_		_	_	0	0
											V <sub>COMD</sub>	= 1.06V
		0	0	0	0	0	0	0	0	0	0	0
Aux-ADC	0	0 Aux-ADC = ON, Conversion = IDLE, Aux-ADC REF = 2.048V, MUX = ADC1, Averaging = 1, Clock Divider = 1, DOUT = Disabled										
ENABLE-8										1	1	1
	_	-   -			_					FD mode		
WAKEUP-SEL										1	1	1
WARLON-OLL										Wake-up state = FD mode		

## Table 6. MAX19713 Default (Power-On) Register Settings

# Table 7. Aux-DAC Enable Table(ENABLE-16 Mode)

E6	E5	E4	Aux-DAC3	Aux-DAC2	Aux-DAC1			
0	0	0	ON	ON	ON			
0	0	1	ON	ON	OFF			
0	1	0	ON	OFF	ON			
0	1	1	ON	OFF	OFF			
1	0	0	OFF	ON	ON			
1	0	1	OFF	ON	OFF			
1	1	0	OFF	OFF	ON			
1	1	1	OFF	OFF	OFF			
0	0	0	Default mode					

# Table 8. Aux-ADC Enable Table(ENABLE-16 Mode)

E9	SELECTION
0 (Default)	Aux-ADC is Powered ON
1	Aux-ADC is Powered OFF

#### FD Mode

The MAX19713 features an FD mode, which is ideal for applications supporting frequency-division duplex. In FD mode, both Rx ADC and Tx DAC, as well as their respective digital buses, are active and the device can receive and transmit simultaneously. Switching from FD mode to other Rx or Tx modes is fast  $(0.1\mu s)$  since the on-board

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

BITS I	05–IO0 WHEN IN	IOFFSET MODE, E	BITS QO5-QO0 W	HEN IN QOFFSET	MODE	OFFSET 1 LSB =
IO5/QO5	IO4/QO4	IO3/QO3	IO2/QO2	IO1/QO1	IO0/QO0	(VFS <sub>P-P</sub> /1023)
1	1	1	1	1	1	-31 LSB
1	1	1	1	1	0	-30 LSB
1	1	1	1	0	1	-29 LSB
•	•	•	•	•	•	•
•	•	•	•	•	•	•
•	•	•	•	•	•	•
1	0	0	0	1	0	-2 LSB
1	0	0	0	0	1	-1 LSB
1	0	0	0	0	0	0mV
0	0	0	0	0	0	0mV (Default)
0	0	0	0	0	1	1 LSB
0	0	0	0	1	0	2 LSB
•	•	•	•	•	•	•
•	•	•	•	•	•	•
•	•	•	•	•	•	•
0	1	1	1	0	1	29 LSB
0	1	1	1	1	0	30 LSB
0	1	1	1	1	1	31 LSB

## Table 9. Offset Control Bits for ID and QD Channels (IOFFSET or QOFFSET Mode)

**Note:**  $1 LSB = (800mV_{P-P}/1023) = 0.782mV.$ 

# Table 10. Common-Mode Select (COMSEL Mode)

CM1	CM0	Tx PATH OUTPUT COMMON MODE (V)
0	0	1.06 (Default)
0	1	0.94
1	0	0.82
1	1	0.71

converters are already powered. Consequently, power consumption in this mode is the maximum of all operating modes. In FD mode the MAX19713 consumes 91.8mW.

#### Wake-Up Function

The MAX19713 uses the SPI interface to control the operating modes of the device including the shutdown and wake-up functions. Once the device has been placed in shutdown through the appropriate SPI command, the first pulse on  $\overline{CS}$ /WAKE performs a wake-up function. At the first rising edge of  $\overline{CS}$ /WAKE, the MAX19713 is forced to a preset operating mode determined by the WAKEUP-SEL register. This mode is termed the wake-up state. If

## Table 11. WAKEUP-SEL Register

W2	W1	W0	POWER MODE AFTER WAKE-UP (WAKE-UP STATE)
0	0	0	Invalid Value. This value is ignored when inadvertently written to the WAKEUP-SEL register.
0	0	1	IDLE
0	1	0	STBY
0	1	1	SPI1-SLOW Rx
1	0	0	SPI2-SLOW Tx
1	0	1	SPI3-FAST Rx
1	1	0	SPI4-FAST Tx
1	1	1	FD ( <b>Default</b> )

the WAKEUP-SEL register has not been programmed, the wake-up state for the MAX19713 is FD mode by default (Table 6, Table 11). The WAKEUP-SEL register cannot be programmed with W2 = 0, W1 = 0, and W0 = 0. If this value is inadvertently written to the device, it is ignored and the register continues to store its previous

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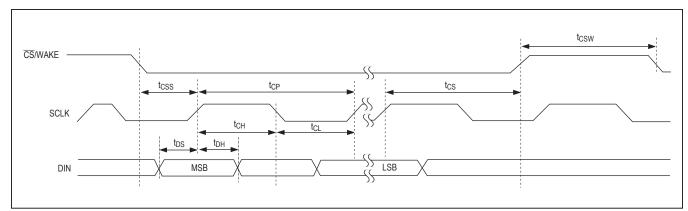


Figure 6. Serial-Interface Timing Diagram

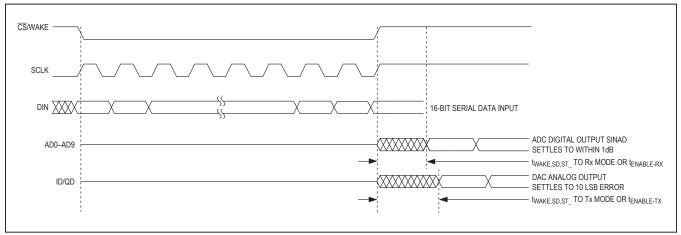


Figure 7. Mode-Recovery Timing Diagram

value. Upon wake-up, the MAX19713 enters the power mode determined by the WAKEUP-SEL register, however, all other settings (Tx DAC offset, Tx DAC commonmode voltage, aux-DAC settings, aux-ADC state) are restored to their values prior to shutdown.

The only SPI line that is monitored by the MAX19713 during shutdown is  $\overline{CS}$ /WAKE. Any information transmitted to the MAX19713 concurrent with the  $\overline{CS}$ /WAKE wake-up pulse is ignored.

#### **SPI** Timing

The serial digital interface is a standard 3-wire connection ( $\overline{CS}$ /WAKE, SCLK, DIN) compatible with SPI/ QSPI<sup>TM</sup>/MICROWIRE/DSP interfaces. Set  $\overline{CS}$ /WAKE low to enable the serial data loading at DIN or output at DOUT. Following a  $\overline{CS}$ /WAKE high-to-low transition, data is shifted synchronously, most significant bit first, on the rising edge of the serial clock (SCLK). After 16 bits are loaded into the serial input register, data is transferred to the latch when  $\overline{CS}$ /WAKE transitions high.  $\overline{CS}$ /WAKE must transition high for a minimum of 80ns before the next write sequence. SCLK can idle either high or low between transitions. Figure 6 shows the detailed timing diagram of the 3-wire serial interface.

#### **Mode-Recovery Timing**

Figure 7 shows the mode-recovery timing diagram.  $t_{WAKE}$  is the wake-up time when exiting shutdown, idle, or standby mode and entering Rx, Tx, or FD mode.  $t_{ENABLE}$  is the recovery time when switching between either Rx or Tx mode.  $t_{WAKE}$  or  $t_{ENABLE}$  is the time for the Rx ADC to settle within 1dB of specified SINAD performance and Tx DAC settling to 10 LSB error.  $t_{WAKE}$  and  $t_{ENABLE}$  times are measured after the 16-bit serial command is latched into the MAX19713 by a  $\overline{CS}$ /WAKE transition high. In FAST mode, the recovery time is 0.1µs to switch between Tx or Rx modes.

QSPI is a trademark of Motorola, Inc.

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

#### System Clock Input (CLK)

Both the Rx ADC and Tx DAC share the CLK input. The CLK input accepts a CMOS-compatible signal level set by  $OV_{DD}$  from 1.8V to  $V_{DD}$ . Since the interstage conversion of the device depends on the repeatability of the rising and falling edges of the external clock, use a clock with low jitter and fast rise and fall times (< 2ns). Specifically, sampling occurs on the rising edge of the clock signal, requiring this edge to provide the lowest possible jitter. Any significant clock jitter limits the SNR performance of the on-chip Rx ADC as follows:

$$SNR = 20 \times log \left(\frac{1}{2 \times \pi \times f_{IN} \times t_{AJ}}\right)$$

where  $f_{\text{IN}}$  represents the analog input frequency and  $t_{\text{AJ}}$  is the time of the clock jitter.

Clock jitter is especially critical for undersampling applications. Consider the clock input as an analog input and route away from any analog input or other digital signal lines. The MAX19713 clock input operates with an  $OV_{DD}/2$  voltage threshold and accepts a 50% ±10% duty cycle.

When the clock signal is stopped at CLK input (CLK = 0 or  $OV_{DD}$ ), all internal registers hold their last value and the MAX19713 saves the last power-management mode or Tx/Rx/FD command. All converter circuits (Rx ADC, Tx DAC, aux-ADC, and aux-DACs) hold their last value. When the clock signal is restarted at CLK, allow 3.8µs (clock wake-up time) for the internal clock circuitry to settle before updating the Tx DAC, reading a valid Rx ADC conversion result, or starting an aux-ADC conversion. This ensures the converters (Rx ADC, Tx DAC, aux-ADC) meet all dynamic performance specifications. The aux-DAC channels are not dependent on CLK, so they can be updated when CLK is idle.

#### 12-Bit, Auxiliary Control DACs

The MAX19713 includes three 12-bit aux-DACs (DAC1, DAC2, DAC3) with 1µs settling time for controlling variable- gain amplifier (VGA), automatic gain-control (AGC), and automatic frequency-control (AFC) functions. The aux-DAC output range is 0.2V to 2.57V as defined by  $V_{OH}$  -  $V_{OL}$ . During power-up, the VGA and AGC outputs (DAC2 and DAC3) are at zero. The AFC DAC (DAC1) is at 1.1V during power-up. The aux-DACs can be independently controlled through the SPI bus, except during SHDN mode where the aux-DACs are turned off completely and the output voltage is set to zero. In STBY and IDLE modes the aux-DACs maintain the last value. On wake-up from SHDN, the aux-DACs resume the last values.

Loading on the aux-DAC outputs should be carefully observed to achieve the specified settling time and stability. The capacitive load must be kept to a maximum of 5pF including package and trace capacitance. The resistive load must be greater than  $200k\Omega$ . If capacitive loading exceeds 5pF, then add a  $10k\Omega$  resistor in series with the output. Adding the series resistor helps drive larger load capacitance (< 15pF) at the expense of slower settling time.

#### 10-Bit, 333ksps Auxiliary ADC

The MAX19713 integrates a 333ksps, 10-bit aux-ADC with an input 4:1 multiplexer. In the aux-ADC mode register, setting bit AD0 begins a conversion with the auxiliary ADC. Bit AD0 automatically clears when the conversion is complete. Setting or clearing AD0 during a conversion has no effect (Table 12). Bit AD1 determines the internal reference of the auxiliary ADC (Table 13). Bits AD2 and AD3 determine the auxiliary ADC input source (Table 14). Bits AD4, AD5, and AD6 select the number of averages taken when a single start-convert command is given. The conversion time increases as the number of averages increases (Table 15). The conversion clock can be divided down from the system clock by properly setting bits AD7, AD8, and AD9 (Table 16). The aux-ADC output data can be written out of DOUT by setting bit AD10 high (Table 17).

The aux-ADC features a 4:1 input multiplexer to allow measurements on four input sources. The input sources are selected by AD3 and AD2 (Table 14). Two of the multiplexer inputs (ADC1 and ADC2) can be connected to external sources such as an RF power detector like the MAX2208 or temperature sensor like the MAX6613. The other two multiplexer inputs are internal connections to V<sub>DD</sub> and OV<sub>DD</sub> that monitor the powersupply voltages. The internal  $V_{DD}$  and  $OV_{DD}$  connections are made through integrated dividers that yield  $V_{DD}/2$  and  $OV_{DD}/2$ measurement results. The aux- ADC voltage reference can be selected between an internal 2.048V bandgap reference or V<sub>DD</sub> (Table 13). The V<sub>DD</sub> reference selection is provided to allow measurement of an external voltage source with a full-scale range extending beyond the 2.048V level. The input source voltage range cannot extend above V<sub>DD</sub>.

The conversion requires 12 clock edges (1 for input sampling, 1 for each of the 10 bits, and 1 at the end for loading into the serial output register) to complete one conversion cycle (when no averaging is being done). Each conversion of an average (when averaging is set greater than 1) requires 12 clock edges. The conversion clock is generated from the system clock input (CLK). An SPI-programmable divider divides the system clock by the appropriate divisor (set with bits AD7, AD8, and

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

### Table 12. Auxiliary ADC Convert

AD0	SELECTION
0	Aux-ADC Idle (Default)
1	Aux-ADC Start-Convert

### **Table 13. Auxiliary ADC Reference**

AD1	SELECTION
0	Internal 2.048V Reference (Default)
1	Internal V <sub>DD</sub> Reference

#### Table 14. Auxiliary ADC Input Source

AD3	AD2	Aux-ADC INPUT SOURCE
0	0	ADC1 (Default)
0	1	ADC2
1	0	V <sub>DD</sub> /2
1	1	OV <sub>DD</sub> /2

### Table 15. Auxiliary ADC Averaging

AD6	AD5	AD4	Aux-ADC AVERAGING
0	0	0	1 Conversion (No Averaging) (Default)
0	0	1	Average of 2 Conversions
0	1	0	Average of 4 Conversions
0	1	1	Average of 8 Conversions
1	0	0	Average of 16 Conversions
1	0	1	Average of 32 Conversions
1	1	Х	Average of 32 Conversions

X = Don't care.

AD9; <u>Table 16</u>) and provides the conversion clock to the auxiliary ADC. The auxiliary ADC has a maximum conversion rate of 333ksps. The maximum conversion clock frequency is 4MHz (333ksps x 12 clocks). Choose the proper divider value to keep the conversion clock frequency under 4MHz, based upon the system CLK frequency supplied to the MAX19713 (<u>Table 16</u>). The total conversion time ( $t_{CONV}$ ) of the auxiliary ADC can be calculated as  $t_{CONV} = (12 \times N_{AVG} \times N_{DIV})/f_{CLK}$ ; where  $N_{AVG}$  is the number of averages (<u>Table 15</u>),  $N_{DIV}$  is the CLK divisor (<u>Table 16</u>), and  $f_{CLK}$  is the system CLK frequency.

# Table 16. Auxiliary ADC Clock (CLK)Divider

AD9	AD8	AD7	Aux-ADC CONVERSION CLOCK
0	0	0	CLK Divided by 1 (Default)
0	0	1	CLK Divided by 2
0	1	0	CLK Divided by 4
0	1	1	CLK Divided by 8
1	0	0	CLK Divided by 16
1	0	1	CLK Divided by 32
1	1	0	CLK Divided by 64
1	1	1	CLK Divided by 128

# Table 17. Auxiliary ADC Data OutputMode

AD10	SELECTION
0	Aux-ADC Data is Not Available on DOUT (Default)
1	Aux-ADC Enters Data Output Mode Where Data is Available on DOUT

### Reading DOUT from the Aux-ADC

DOUT is normally in a high-impedance condition. Upon setting the auxiliary ADC start conversion bit (bit AD0), DOUT becomes active and goes high, indicating that the aux-ADC is busy. When the conversion cycle is complete (including averaging), the data is placed into an output register and DOUT goes low, indicating that the output data is ready to be driven onto DOUT. When bit AD10 is set (AD10 = 1), the aux-ADC enters a data output mode where data is available at DOUT on the next low assertion of  $\overline{CS}$ /WAKE. The auxiliary ADC data is shifted out of DOUT (MSB first) with the data transitioning on the falling edge of the serial clock (SCLK). Since a DOUT read requires 16 bits, DOUT holds the value of the last conversion data bit for the last 6 bits (6 least significant bits) following the aux-ADC conversion data. DOUT enters a high-impedance state when CS/WAKE is deasserted high. When bit AD10 is cleared (AD10 = 0), the aux-ADC data is not available on DOUT (Table 17).

After the aux-ADC completes a conversion, the data result is loaded to an output register waiting to be shifted out. No further conversions are possible until data is shifted out. This means that if the first conversion command sets AD10 = 0, AD0 = 1, then it cannot be followed by conversion commands setting AD10 = 0, AD0 = 1 or AD10 = 1, AD0 = 1. If this sequence of commands is inadvertently used then DOUT is disabled. To resume normal operation set AD0 = 0.

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The fastest method to perform sequential conversions with the aux-ADC is by sending consecutive commands setting AD10 = 1, AD0 = 1. With this sequence the  $\overline{CS}$ /WAKE falling edge shifts data from the previous conversion on to DOUT and the rising edge of  $\overline{CS}$ /WAKE loads

the next conversion command at DIN. Allow enough time for each conversion to complete before sending the next conversion command. See <u>Figure 8</u> for single and continuous conversion examples.

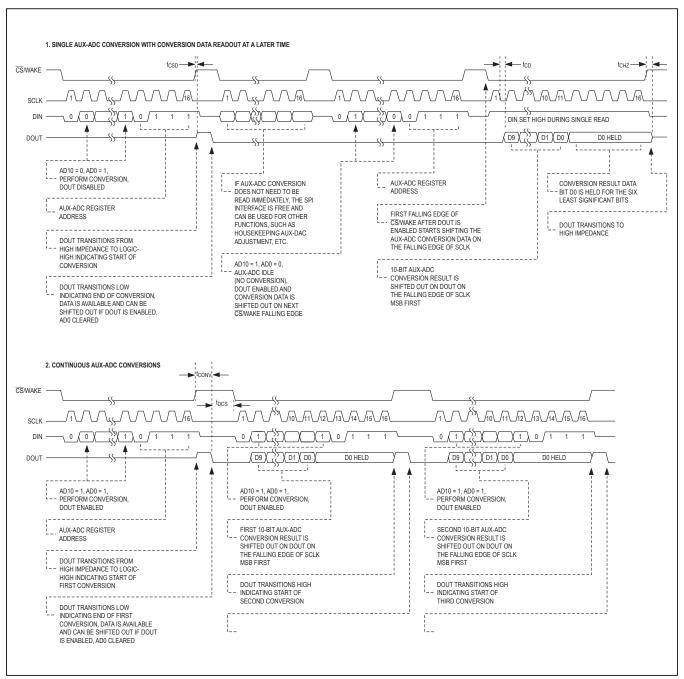


Figure 8. Aux-ADC Conversions Timing

DIN can be written independent of DOUT state. A 16-bit instruction at DIN updates the device configuration. To prevent modifying internal registers while reading data from DOUT, hold DIN at a high state (only applies if sequential aux-ADC conversions are not executed). This effectively writes all ones into address 1111. Since address 1111 does not exist, no internal registers are affected.

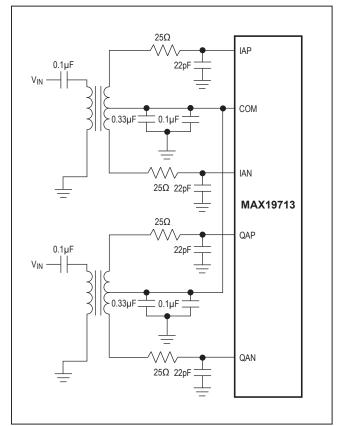


Figure 9. Balun Transformer-Coupled Single-Ended-to-Differential Input Drive for Rx ADC

#### **Reference Configurations**

The MAX19713 features an internal precision 1.024Vbandgap reference that is stable over the entire powersupply and temperature ranges. The REFIN input provides two modes of reference operation. The voltage at REFIN ( $V_{REFIN}$ ) sets the reference operation mode (Table 18).

In internal reference mode, connect REFIN to V<sub>DD</sub>. V<sub>REF</sub> is an internally generated 0.512V ±4% reference level. COM, REFP, and REFN are low-impedance outputs with V<sub>COM</sub> = V<sub>DD</sub>/2, V<sub>REFP</sub> = V<sub>DD</sub>/2 + V<sub>REF</sub>/2, and V<sub>REFN</sub> = V<sub>DD</sub>/2 - V<sub>REF</sub>/2. Bypass REFP, REFN, and COM each with a 0.33µF capacitor. Bypass REFIN to GND with a 0.1µF capacitor.

In buffered external reference mode, apply 1.024V ±10% at REFIN. In this mode, COM, REFP, and REFN are low-impedance outputs with  $V_{COM} = V_{DD}/2$ ,  $V_{REFP} = V_{DD}/2 + V_{REFIN}/4$ , and  $V_{REFN} = V_{DD}/2 - V_{REFIN}/4$ . Bypass REFP, REFN, and COM each with a 0.33µF capacitor. Bypass REFIN to GND with a 0.1µF capacitor. In this mode, the Tx DAC full-scale output is proportional to the external reference. For example, if the  $V_{REFIN}$  is increased by 10% (max), the Tx DAC full-scale output is also increased by 10% or ±440mV.

### **Applications Information**

#### Using Balun Transformer AC-Coupling

An RF transformer (Figure 9) provides an excellent solution to convert a single-ended signal source to a fully differential signal for optimum ADC performance. Connecting the center tap of the transformer to COM provides a  $V_{DD}/2$  DC level shift to the input. A 1:1 transformer can be used, or a step-up transformer can be selected to reduce the drive requirements. In general, the MAX19713 provides better SFDR and THD with fully differential input signals than single-ended signals, especially for high input frequencies. In differential mode, even-order harmonics are lower as both inputs (IAP, IAN, QAP, QAN) are balanced, and each of the Rx ADC inputs

V <sub>REFIN</sub>	REFERENCE MODE
> 0.8V x V <sub>DD</sub>	Internal Reference Mode. $V_{REF}$ is internally generated to be 0.512V. Bypass REFP, REFN, and COM each with a 0.33 $\mu$ F capacitor.
1.024V ±10%	Buffered External Reference Mode. An external 1.024V $\pm$ 10% reference voltage is applied to REFIN. V <sub>REF</sub> is internally generated to be V <sub>REFIN</sub> /2. Bypass REFP, REFN, and COM each with a 0.33µF capacitor. Bypass REFIN to GND with a 0.1µF capacitor.

## Table 18. Reference Modes

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only requires half the signal swing compared to singleended mode. Figure 10 shows an RF transformer converting the MAX19713 Tx DAC differential analog outputs to single-ended.

#### Using Op-Amp Coupling

Drive the MAX19713 Rx ADC with op amps when a balun transformer is not available. Figure 11 and Figure 12 show the Rx ADC being driven by op amps for AC-coupled single-ended and DC-coupled differential applications. Amplifiers such as the MAX4454 and MAX4354 provide high speed, high bandwidth, low noise, and low distortion to maintain the input signal integrity. The op-amp circuit shown in Figure 12 can also be used to interface with the Tx DAC differential analog outputs to provide gain or buffering. The Tx DAC differential analog outputs cannot be used in single-ended mode because of the internally generated common-mode level. Also, the Tx DAC analog outputs are designed to drive a differential input stage with input impedance  $\geq 70k\Omega$ . If single-ended outputs are desired, use an amplifier to provide differential-to-singleended conversion and select an amplifier with proper input common-mode voltage range.

#### **FDD** Application

Figure 13 illustrates a typical FDD application circuit. The MAX19713 interfaces directly with the radio front-ends to provide a complete "RF-to-Bits" solution for FDD applications such as 802.11, 802.16, WCDMA, and proprietary radio systems. The MAX19713 provides several system benefits to digital baseband developers:

- Fast Time-to-Market
- High-Performance, Low-Power Analog Functions
- Low-Risk, Proven Analog Front-End Solution
- No Mixed-Signal Test Times
- No NRE Charges
- No IP Royalty Charges
- Enables Digital Baseband and Scale with 65nm to 90nm CMOS

# Grounding, Bypassing, and Board Layout

The MAX19713 requires high-speed board layout design techniques. Refer to the MAX19713 EV kit data sheet for a board layout reference. Place all bypass capacitors as close to the device as possible, preferably on the same side of the board as the device, using surface-mount devices for minimum inductance. Bypass V<sub>DD</sub> to GND with a 0.1µF ceramic capacitor in parallel with a 2.2µF capacitor. Bypass OV<sub>DD</sub> to OGND with a 0.1µF ceramic

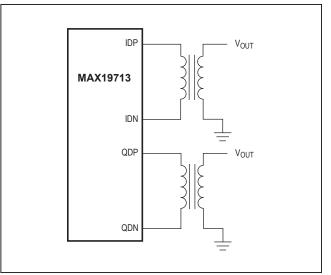


Figure 10. Balun Transformer-Coupled Differential-to-Single-Ended Output Drive for Tx DAC

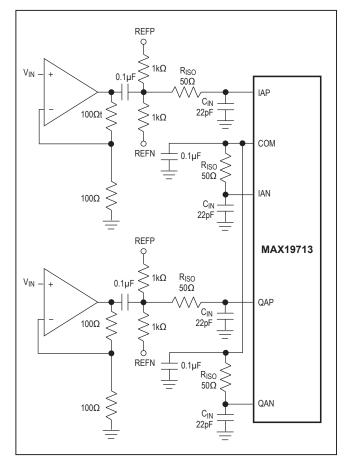


Figure 11. Single-Ended Drive for Rx ADC

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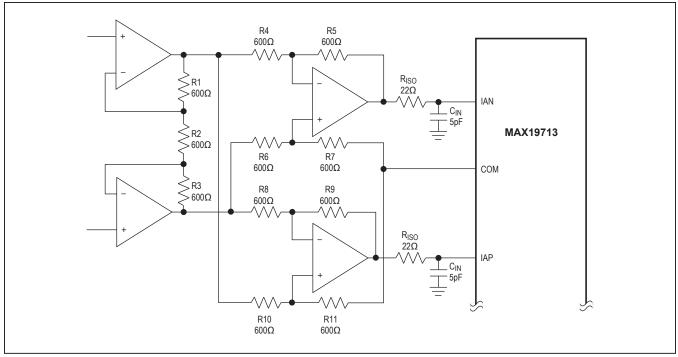


Figure 12. Rx ADC DC-Coupled Differential Drive

capacitor in parallel with a  $2.2\mu$ F capacitor. Bypass REFP, REFN, and COM each to GND with a  $0.33\mu$ F ceramic capacitor. Bypass REFIN to GND with a  $0.1\mu$ F capacitor.

Multilayer boards with separated ground and power planes yield the highest level of signal integrity. Use a split ground plane arranged to match the physical location of the analog ground (GND) and the digital output-driver ground (OGND) on the device package. Connect the MAX19713 exposed backside paddle to the GND plane. Join the two ground planes at a single point so the noisy digital ground currents do not interfere with the analog ground plane. The ideal location for this connection can be determined experimentally at a point along the gap between the two ground planes. Make this connection with a low-value, surface-mount resistor ( $1\Omega$  to  $5\Omega$ ), a ferrite bead, or a direct short. Alternatively, all ground plane is sufficiently isolated from any noisy digital system's ground

plane (e.g., downstream output buffer or DSP ground plane).

Route high-speed digital signal traces away from sensitive analog traces. Make sure to isolate the analog input lines to each respective converter to minimize channelto-channel crosstalk. Keep all signal lines short and free of 90° turns.

## **Dynamic Parameter Definitions**

#### **ADC and DAC Static Parameter Definitions**

#### Integral Nonlinearity (INL)

Integral nonlinearity is the deviation of the values on an actual transfer function from a straight line. This straight line can be either a best-straight-line fit or a line drawn between the end points of the transfer function, once offset and gain errors have been nullified. The static linearity parameters for the device are measured using the beststraight-line fit (DAC Figure 14a).

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

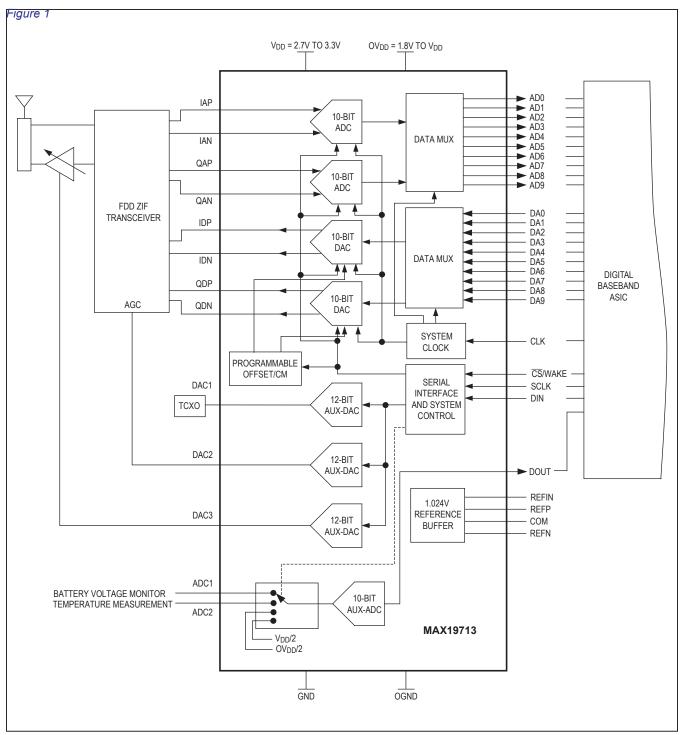


Figure 13. Typical FDD Radio Application Circuit

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

#### **Differential Nonlinearity (DNL)**

Differential nonlinearity is the difference between an actual step width and the ideal value of 1 LSB. A DNL error specification of less than 1 LSB guarantees no missing codes (ADC) and a monotonic transfer function (ADC and DAC) (DAC Figure 14b).

#### **ADC Offset Error**

Ideally, the midscale transition occurs at 0.5 LSB above midscale. The offset error is the amount of deviation between the measured transition point and the ideal transition point.

#### **DAC Offset Error**

Offset error (Figure 14a) is the difference between the ideal and actual offset point. The offset point is the output value when the digital input is midscale. This error affects all codes by the same amount and usually can be compensated by trimming.

#### **ADC Gain Error**

Ideally, the ADC full-scale transition occurs at 1.5 LSB below full scale. The gain error is the amount of deviation between the measured transition point and the ideal transition point with the offset error removed.

#### **ADC Dynamic Parameter Definitions**

#### **Aperture Jitter**

<u>Figure 15</u> shows the aperture jitter  $(t_{AJ})$ , which is the sample-to-sample variation in the aperture delay.

#### **Aperture Delay**

Aperture delay  $(t_{AD})$  is the time defined between the rising edge of the sampling clock and the instant when an actual sample is taken (Figure 15).

#### Signal-to-Noise Ratio (SNR)

For a waveform perfectly reconstructed from digital samples, the theoretical maximum SNR is the ratio of the fullscale analog input (RMS value) to the RMS quantization error (residual error) and results directly from the ADC's resolution (N bits):

#### $SNR(max) = 6.02 \times N + 1.76$ (in dB)

In reality, there are other noise sources besides quantization noise: thermal noise, reference noise, clock jitter, etc. SNR is computed by taking the ratio of the RMS signal to the RMS noise. RMS noise includes all spectral components to the Nyquist frequency excluding the fundamental, the first five harmonics, and the DC offset.

#### Signal-to-Noise and Distortion (SINAD)

SINAD is computed by taking the ratio of the RMS signal to the RMS noise. RMS noise includes all spectral components to the Nyquist frequency excluding the fundamental and the DC offset.

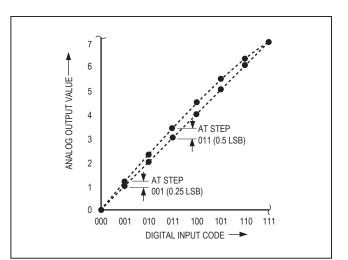


Figure 14a. Integral Nonlinearity

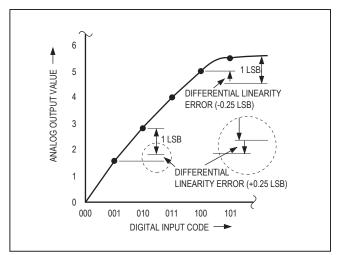


Figure 14b. Differential Nonlinearity

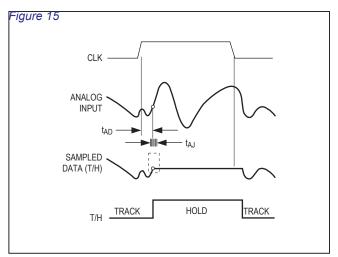


Figure 15. T/H Aperture Timing

#### Effective Number of Bits (ENOB)

ENOB specifies the dynamic performance of an ADC at a specific input frequency and sampling rate. An ideal ADC's error consists of quantization noise only. ENOB for a full-scale sinusoidal input waveform is computed from:

#### **Total Harmonic Distortion (THD)**

THD is typically the ratio of the RMS sum of the first five harmonics of the input signal to the fundamental itself. This is expressed as:

$$THD = 20 \times log \left[ \frac{\sqrt{(V_2^2 + V_3^2 + V_4^2 + V_5^2 + V_6^2)}}{V_1} \right]$$

where  $V_1$  is the fundamental amplitude and  $V_2-V_6$  are the amplitudes of the 2nd- through 6th-order harmonics.

#### **Third Harmonic Distortion (HD3)**

HD3 is defined as the ratio of the RMS value of the third harmonic component to the fundamental input signal.

#### Spurious-Free Dynamic Range (SFDR)

SFDR is the ratio expressed in decibels of the RMS amplitude of the fundamental (maximum signal component) to the RMS value of the next-largest spurious component, excluding DC offset.

#### Intermodulation Distortion (IMD)

IMD is the total power of the intermodulation product relative to the total input power when two tones,  $f_{IN1}$  and  $f_{IN2}$ , are present at the inputs. The intermodulation products are ( $f_{IN1} \pm f_{IN2}$ ), (2 x  $f_{IN1}$ ), (2 x  $f_{IN2}$ ), (2 x  $f_{IN1} \pm f_{IN2}$ ), (2 x  $f_{IN1}$ ). (2 x  $f_{IN2}$ ), (2 x  $f_{IN1} \pm f_{IN2}$ ), (2 x  $f_{I$ 

#### **3rd-Order Intermodulation (IM3)**

IM3 is the power of the worst 3rd-order intermodulation product relative to the input power of either input tone when two tones,  $f_{IN1}$  and  $f_{IN2}$ , are present at the inputs. The 3rd-order intermodulation products are (2 x  $f_{IN1} \pm f_{IN2}$ ), (2 x  $f_{IN2} \pm f_{IN1}$ ). The individual input tone levels are at -7dBFS.

#### **Power-Supply Rejection**

Power-supply rejection is defined as the shift in offset and gain error when the power supply is changed  $\pm 5\%$ .

#### **Small-Signal Bandwidth**

A small -20dBFS analog input signal is applied to an ADC in such a way that the signal's slew rate does not limit the ADC's performance. The input frequency is then swept up to the point where the amplitude of the digitized conversion result has decreased by 3dB. Note that the T/H performance is usually the limiting factor for the small-signal input bandwidth.

#### **Full-Power Bandwidth**

A large -0.5dBFS analog input signal is applied to an ADC, and the input frequency is swept up to the point where the amplitude of the digitized conversion result has decreased by 3dB. This point is defined as the full-power bandwidth frequency.

#### **DAC Dynamic Parameter Definitions**

#### **Total Harmonic Distortion**

THD is the ratio of the RMS sum of the output harmonics up to the Nyquist frequency divided by the fundamental:

$$THD = 20 x log \left[ \frac{\sqrt{(V_2^2 + V_3^2 + ... + V_n^2)}}{V_1} \right]$$

where  $V_1$  is the fundamental amplitude and  $V_2$  through  $V_n$  are the amplitudes of the 2nd through nth harmonic up to the Nyquist frequency.

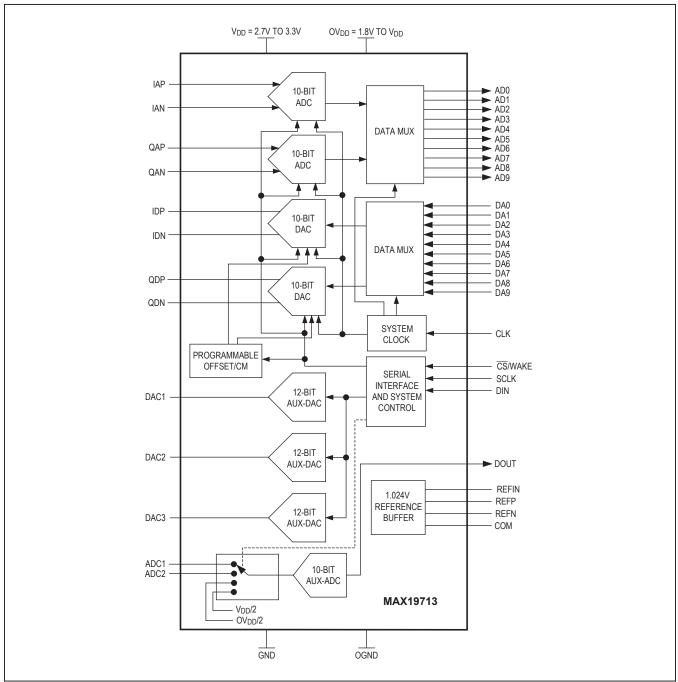
#### **Spurious-Free Dynamic Range**

Spurious-free dynamic range (SFDR) is the ratio of RMS amplitude of the fundamental (maximum signal component) to the RMS value of the next-largest distortion component up to the Nyquist frequency excluding DC.

<b>Selector Guide</b>	
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PART	SAMPLING RATE (Msps)	INTEGRATED CDMA Tx FILTERS
MAX19710	7.5	No
MAX19711	11	Yes
MAX19712	22	No
MAX19713	45	No

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

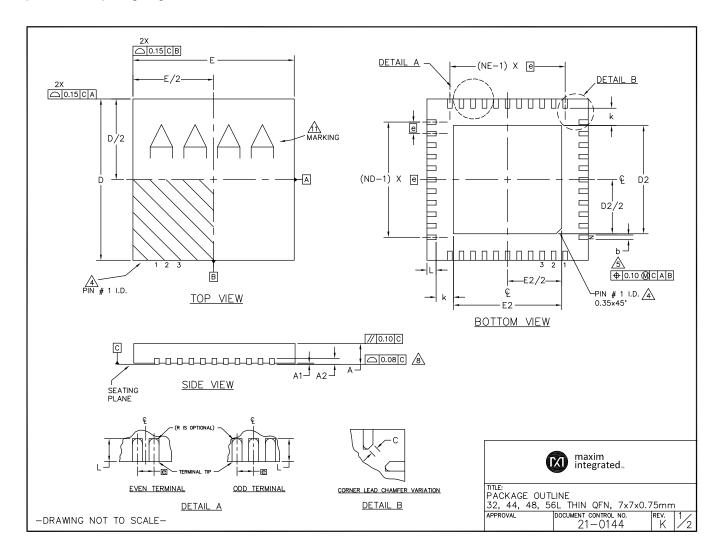


# **Functional Diagram**

# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## **Package Information**

For the latest package outline information and land patterns (footprints), go to <u>www.maximintegrated.com/packages</u>. Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.



# 10-Bit, 45Msps, Full-Duplex Analog Front-End

## Package Information (continued)

For the latest package outline information and land patterns (footprints), go to <u>www.maximintegrated.com/packages</u>. Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

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## **Revision History**

Pages changed at Rev 1: 1-4, 29, 37

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